


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541746	<b>Applicant(s)/Patent Under Reexamination</b>  BABA ET AL.
	<b>Examiner</b>  Pepitone, Michael	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
523	106, 107	1/11/08	MFP
523	106, 107, 108	7/21/2008	MFP
351	160h, 160r	3/12/2009	MFP
524	264, 258	3/12/2009	MFP
523	108	10/21/2009	MFP
351	160r	10/21/2009	MFP
523	106, 107, 108	2/26/2010	MFP
351	160h	2/26/2010	MFP
523	106	8/25/2010	MFP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	1/11/08	MFP
inventor name search, PALM	1/11/08	MFP
STN structure search	1/11/08	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	7/21/2008	MFP
updated inventor name search, PALM	7/21/2008	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	3/12/2009	MFP
updated inventor name search, PALM	3/12/2009	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	10/21/2009	MFP
updated inventor name search, PALM	10/21/2009	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	2/26/2010	MFP
updated inventor name search, PALM	2/26/2010	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	8/25/2010	MFP
updated inventor name search, PALM	8/25/2010	MFP

INTERFERENCE SEARCH
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/M. P./ Examiner.Art Unit 1796	
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Class	Subclass	Date	Examiner

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